

# Device Modeling Report

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PART NUMBER: 03P4MG  
MANUFACTURER: NEC



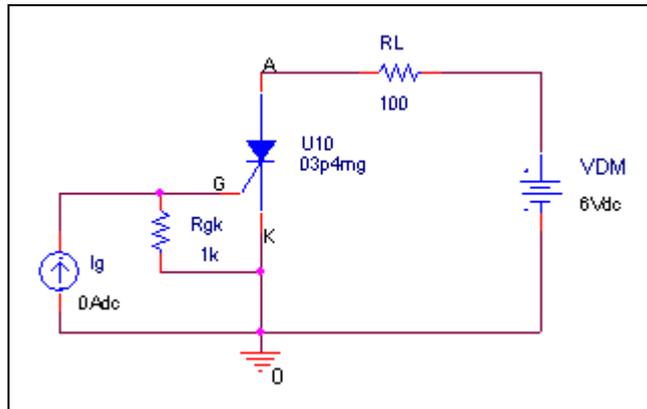
**Bee Technologies Inc.**

## DIODE MODEL

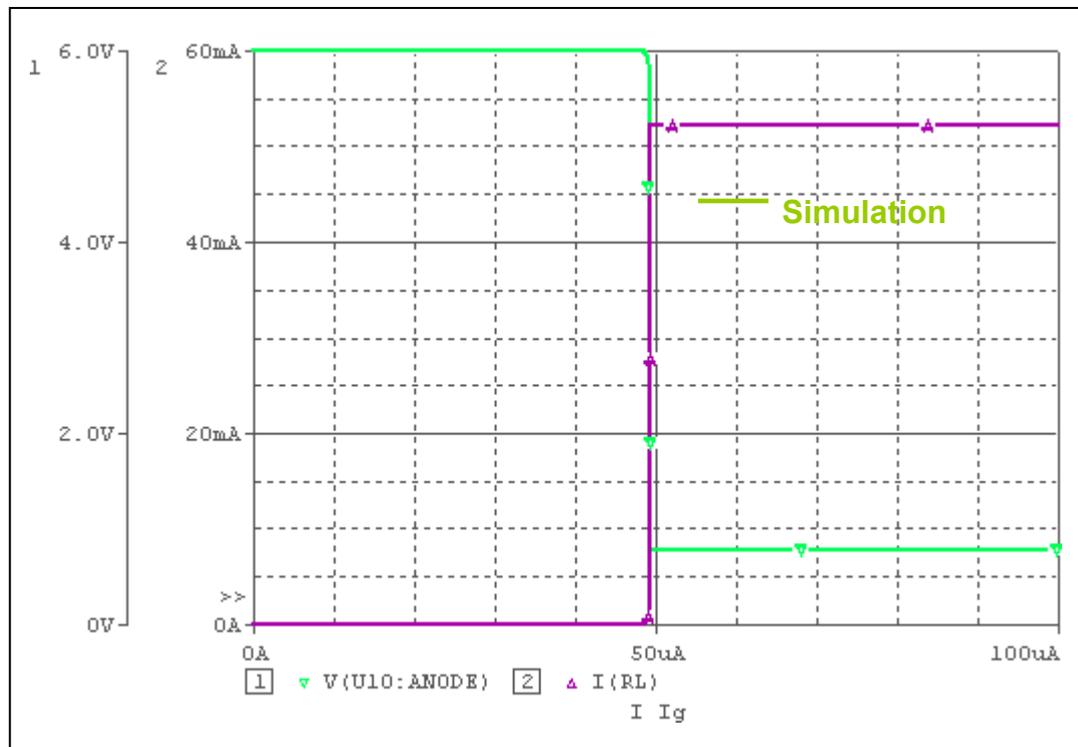
| Pspice model Parameter | Model description                           |
|------------------------|---|
| IS                     | Saturation Current                          |
| N                      | Emission Coefficient                        |
| RS                     | Series Resistance                           |
| IKF                    | High-injection Knee Current                 |
| CJO                    | Zero-bias Junction Capacitance              |
| M                      | Junction Grading Coefficient                |
| VJ                     | Junction Potential                          |
| ISR                    | Recombination Current Saturation Value      |
| BV                     | Reverse Breakdown Voltage(a positive value) |
| IBV                    | Reverse Breakdown Current(a positive value) |
| TT                     | Transit Time                                |

## IG-VT Characteristic

### Evaluation Circuit



### Simulation result

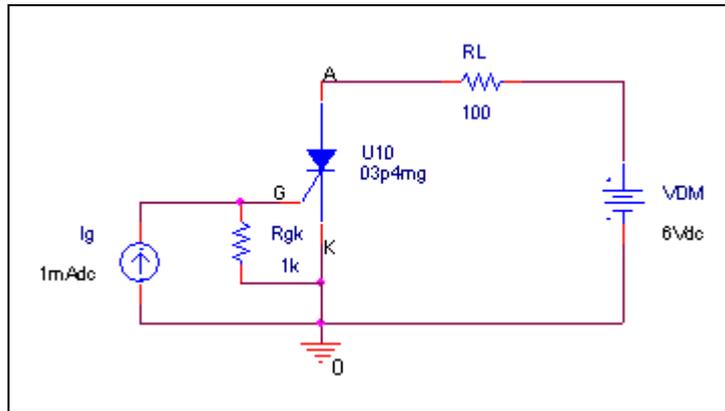


### Comparison Table

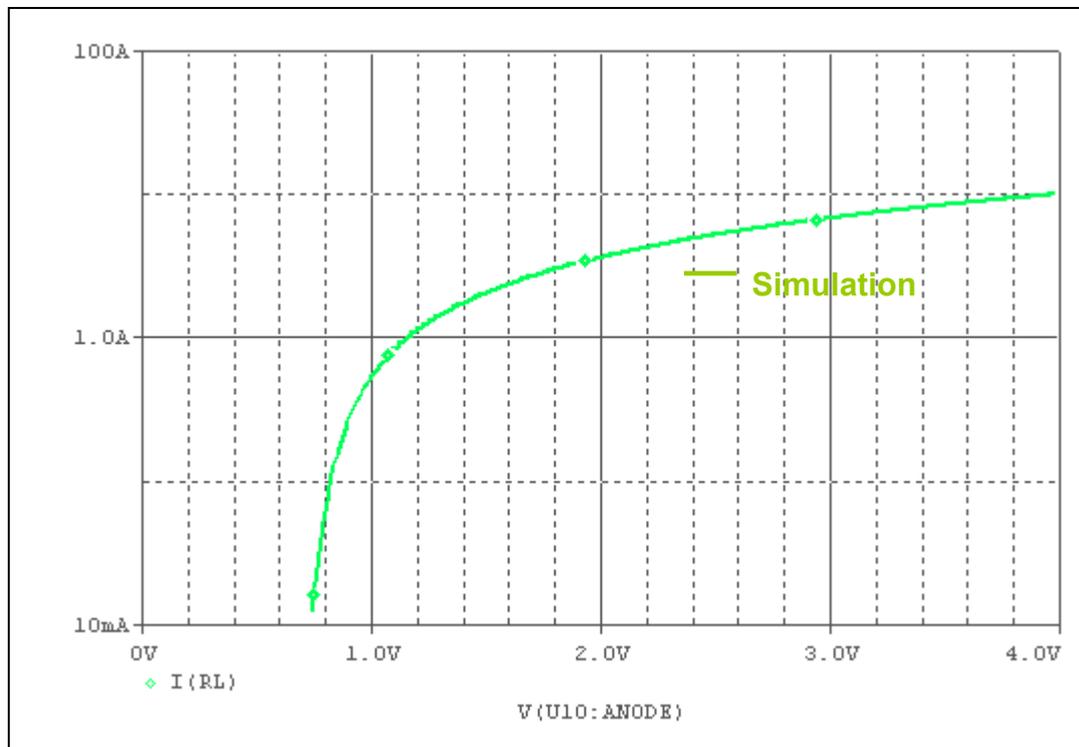
|               | Measurement | Simulation | % Error |
|---------------|-------------|------------|---------|
| $I_{GT}$ (uA) | 50(max)     | 48.691     | 2.6180  |
| $V_{GT}$ (V)  | 0.8(max)    | 0.788856   | 1.3930  |

# ITM-VTM Characteristic

## Evaluation Circuit



## Simulation result

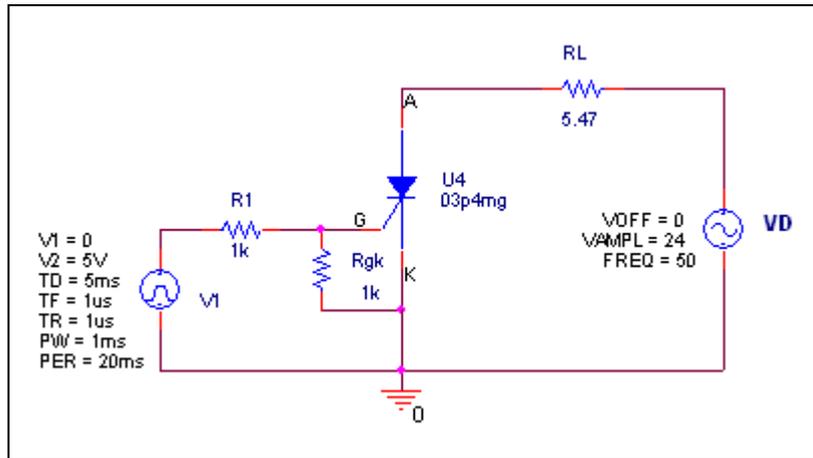


## Comparison Table

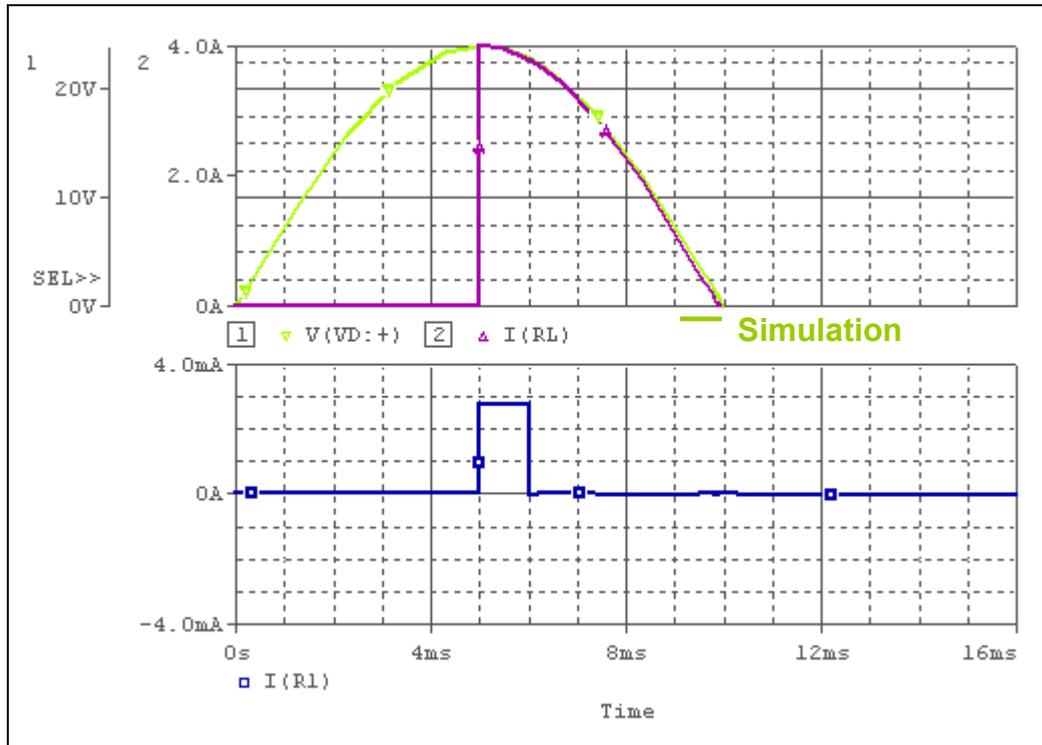
| At ITM=4A | Measurement | Simulation | % Error |
|-----------|-------------|------------|---------|
| VTM(V)    | 2.2(max)    | 2.1172     | 3.7636  |

# Holding Characteristic (IH)

## Evaluation Circuit



## Simulation result

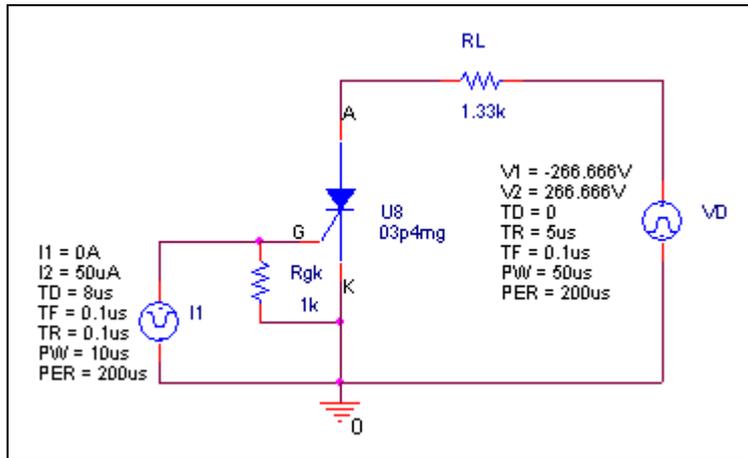


## Comparison Table

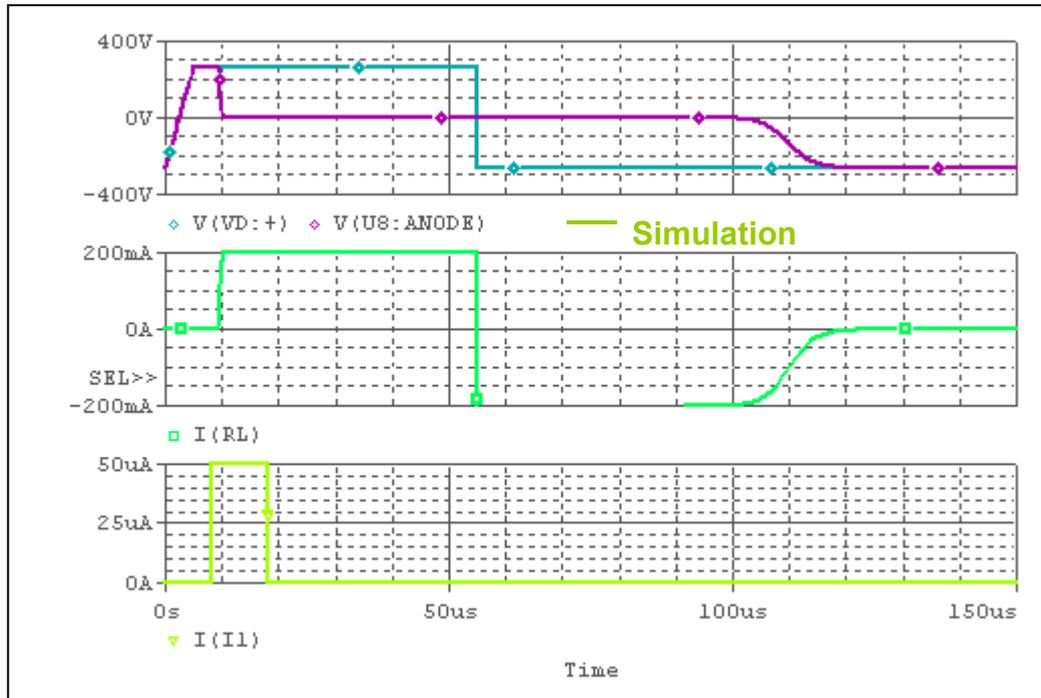
| $V_{DM}=24V, I_{TM}=4A$ | Measurement   | Simulation    | % Error  |
|-------------------------|---------------|---------------|----------|
| <b>IH(mA)</b>           | <b>5(max)</b> | <b>3.5042</b> | <b>0</b> |

# Switching Time Characteristic

## Evaluation Circuit



## Simulation result



## Comparison Table

|          | Measurement | Simulation | %Error |
|----------|-------------|------------|--------|
| Toff(us) | 60          | 59.980     | 0.0333 |